

<b>Notice of References Cited</b>		Application/Control No. 10/660,683	Applicant(s)/Patent Under Reexamination EBISAWA, TAKASHI	
		Examiner JAYESH A. PATEL	Art Unit 2624	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,548,415	08-1996	Tanaka et al.	358/462
*	B	US-6,175,659	01-2001	Huang, Chien-Hsiu	382/266
*	C	US-2002/0008879	01-2002	MORIMATSU, HIROYUKI	358/1.9
*	D	US-5,751,854	05-1998	Saitoh et al.	382/218
*	E	US-6,917,446	07-2005	Tanaka et al.	358/1.9
*	F	US-5,946,416	08-1999	Akagi et al.	382/194
*	G	US-5,583,949	12-1996	Smith et al.	382/199
*	H	US-6,707,953	03-2004	Iida, Kentaro	382/273
*	I	US-6,750,986	06-2004	Yang, Keven	358/462
*	J	US-5,774,578	06-1998	Shimizu, Shinji	382/170
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05-136999	06-1993	Japan	Koike Kazumasa	H04N 1/40
	O	JP 10-240929	09-1998	Japan	Shinozaki Yoshihiko	H04N 5/208
	P	JP 11-150659	06-1999	Japan	Morimatsu Hiroyuki	H04N 1/405
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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